

Notice of References Cited

Application/Control No.

10/695,307

Applicant(s)/Patent Under
Reexamination
SRIDHAR ET AL.

Examiner

M. Wilczewski

Art Unit

2822

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,495,402	12-2002	Yu et al.	438/285
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